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- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- pnp Inputs Reduce dc Loading
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

These octal buffers/drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. When these devices are used with the 'ALS241, 'AS241A, 'ALS244, and 'AS244A, the circuit designer has a choice of selected combinations of inverting and noninverting outputs, symmetrical active-low output-enable (\$\overline{OE}\$) inputs, and complementary OE and \$\overline{OE}\$ inputs. These devices feature high fan-out and improved fan-in.

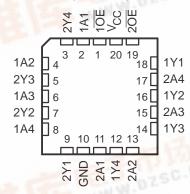
The -1 version of SN74ALS240A is identical to the standard version, except that the recommended maximum I_{OL} for the -1 version is 48 mA. There is no -1 version of the SN54ALS240A.

The SN54ALS240A and SN54AS240A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS240A and SN74AS240A are characterized for operation from 0°C to 70°C.

SN54ALS240A, SN54AS240A . . . J PACKAGE SN74ALS240A, SN74AS240A . . . DW OR N PACKAGE (TOP VIEW)

1 <u>OE</u> [1	20] V _{CC}
1A1 [2	19	2OE
2Y4 [18	1Y1
1A2 [17] 2A4
2Y3 [16] 1Y2
1A3 [6] 2A3
2Y2 [14] 1Y3
1A4 [8	13] 2A2
2Y1 [9	12] 1Y4
GND [10	11] 2A1
		-	

SN54ALS240A, SN54AS240A ... FK PACKAGE (TOP VIEW)



FUNCTION TABLE (each buffer)

INP	JTS	OUTPUT
OE	Α	Υ
L	Н	L
L	L	Н
Н	X	Z

SN54ALS240A, SN54AS240A, SN74ALS240A, SN74AS240A OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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logic symbol†

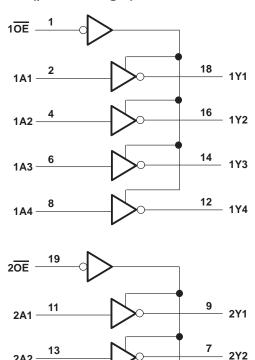
2A3

2A4

17

ΕN 18 1A1 1Y1 4 16 1A2 1Y2 14 1Y3 1A3 8 12 1A4 1Y4 19 2OE ΕN 11 9 ∇ 2A1 2Y1 13 7 2A2 2Y2 15 5

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

2Y3

2Y4

3

Supply voltage, V _{CC}	7 V
Input voltage, V _I	7 V
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T _A : SN54ALS240A	−55°C to 125°C
SN74ALS240A	0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SN54ALS240A, SN54AS240A, SN74ALS240A, SN74AS240A **OCTAL BUFFERS/DRIVERS** WITH 3-STATE OUTPUTS SDAS214C - DECEMBER 1982 - REVISED AUGUST 1995

recommended operating conditions

		SN54ALS240A			SN7	UNIT		
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.7			0.8	V
loH	High-level output current			-12			-15	mA
lai	Low lovel output ourrent	12		24		24	mA	
lOL	Low-level output current						48†	IIIA
TA	Operating free-air temperature	-55		125	0		70	°C

[†] Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST OF	TEST CONDITIONS MI		SN54ALS240A		SN74ALS240A			UNIT
PARAMETER	IESI CI			TYP [‡]	MAX	MIN	TYP [‡]	MAX	UNII
VIK	$V_{CC} = 4.5 V,$	$I_{I} = -18 \text{ mA}$			-1.2			-1.2	V
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	2		V _{CC} -2	2		
Vari		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V
Voн	$V_{CC} = 4.5 V$	$I_{OH} = -12 \text{ mA}$	2						v
		$I_{OH} = -15 \text{ mA}$				2			
		I _{OL} = 12 mA		0.25	0.4		0.25	0.4	
VOL	V _{CC} = 4.5 V	I _{OL} = 24 mA					0.35	0.5	V
		I _{OL} = 48 mA [†]					0.35	0.5	
lozh	V _{CC} = 5.5 V,	V _O = 2.7 V			20			20	μΑ
lozL	V _{CC} = 5.5 V,	V _O = 0.4 V			-20			-20	μΑ
Ι _Ι	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
lін	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1			-0.1	mA
IO§	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA
		Outputs high		4	11		4	11	
l _{CC}	$V_{CC} = 5.5 \text{ V}$	Outputs low		13	23		13	23	mA
		Outputs disabled		14	25		14	25	

 $[\]dagger$ Applies only to the -1 version and only if V_{CC} is between 4.75 V and 5.25 V



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[§] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, Ios.

SN54ALS240A, SN54AS240A, SN74ALS240A, SN74AS240A OCTAL BUFFERS/DRIVERS WITH 3-STATE OUTPUTS

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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V,} \\ C_L = 50 \text{ pF,} \\ R1 = 500 \Omega, \\ R2 = 500 \Omega, \\ T_A = \text{MIN to MAX}^{\dagger} \\ \text{SN54ALS240A} \text{SN74ALS240A}$		UNIT		
			MIN	MAX	MIN	MAX	1
t _{PLH}	Δ	Υ	2	22	2	9	ns
tPHL	A		2	11	2	9	115
^t PZH			4	34	5	13	200
t _{PZL}	ŌĒ	Y	5	26	5	18	ns
^t PHZ	ŌĒ		1	15	2	10	ns
tPLZ	OE .	ľ	3	24	3	12	115

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	7 V
Input voltage, V _I	$\dots \dots \dots \ 7 \ V$
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range, T _A : SN54AS240A	−55°C to 125°C
SN74AS240A	\dots 0°C to 70°C
Storage temperature range	-65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

		SN54AS240A)A	SN74AS240A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
ІОН	High-level output current			-12			-15	mA
loL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

SN54ALS240A, SN54AS240A, SN74ALS240A, SN74AS240A **OCTAL BUFFERS/DRIVERS** WITH 3-STATE OUTPUTS

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TECT OF	TEST CONDITIONS		4AS24	0A	SN7	UNIT			
PARAMETER	lesi Co			TYP [†]	MAX	MIN	TYP [†]	MAX	UNII	
V _{IK}	$V_{CC} = 4.5 \text{ V},$	$I_1 = -18 \text{ mA}$			-1.2			-1.2	V	
	V _{CC} = 4.5 V to 5.5 V	I _{OH} = −2 mA	V _{CC} -2			V _{CC} -2				
Vari	VCC = 4.5 V to 5.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V	
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						V	
	VCC = 4.5 V	$I_{OH} = -15 \text{ mA}$				2.4				
Va	V _{CC} = 4.5 V	I _{OL} = 48 mA		0.27	0.55				V	
VOL	I _{OL} = 64 mA						0.31		V	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			50			50	μΑ	
lozL	$V_{CC} = 5.5 \text{ V},$	V _O = 0.4 V			-50			-50	μΑ	
lį	$V_{CC} = 5.5 \text{ V},$	V _I = 7 V			0.1			0.1	mA	
lн	$V_{CC} = 5.5 \text{ V},$	V _I = 2.7 V			20			20	μΑ	
A inputs	V00 - 5 5 V	V _I = 0.4 V			-1			-1	mA	
IIL OE inputs	V _{CC} = 5.5 V,	V = 0.4 V				-0.5		-0.5	IIIA	
IO [‡]	$V_{CC} = 5.5 \text{ V},$	V _O = 2.25 V	-50		-150	-50		-150	mA	
		Outputs high		11	17		11	17		
Icc	V _{CC} = 5.5 V	Outputs low		51	75		51	75	mA	
		Outputs disabled		24	38		24	38		

switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _C C _L R1 R2 T _A	,	UNIT		
			SN54AS240A		SN74AS240A		
		MIN	MAX	MIN	MAX		
t _{PLH}	Δ	A Y	1	7	1	6.5	ns
t _{PHL}	٨		1.2	6.5	1.2	6.5	115
^t PZH	ŌĒ	V	1	7	1	6.4	ns
^t PZL	OE	Ť	1.1	9.5	1.1	9	113
^t PHZ	ŌĒ	· ·	1.2	5.5	1.2	5	ns
t _{PLZ}	OL .	'	1.5	12.5	1.5	9.5	113

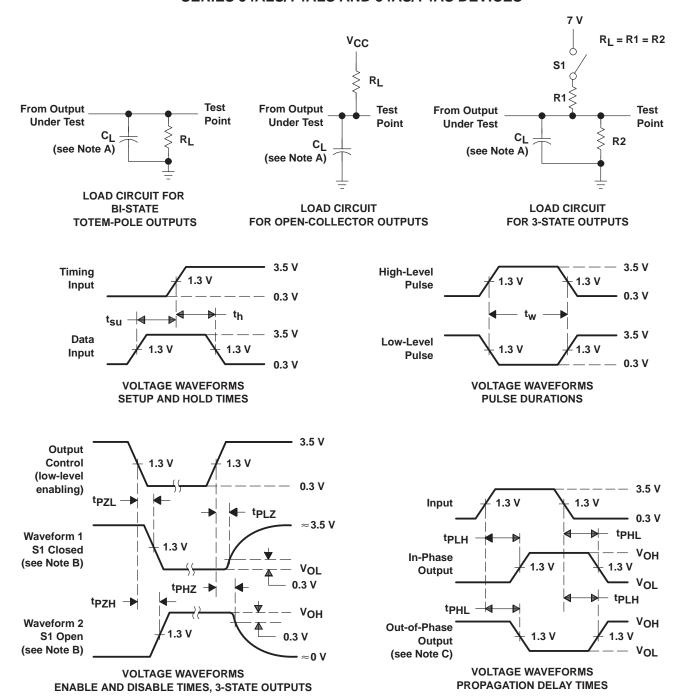
[§] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



[†] All typical values are at V_{CC} = 5 V, T_A = 25°C. ‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

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PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- D. All input pulses have the following characteristics: $PRR \le 1$ MHz, $t_r = t_f = 2$ ns, duty cycle = 50%.
- E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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